Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	10981	324/760-765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/02 16:19
L2	38966	test$4 near5 (IC! or integrated adj circuit)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/02 16:19
L3	3505	L2 and 1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/02 16:19
L4	36	(measur$4 and analyz$4 and test$4) with (computer or control$4) and diagnostic adj signal	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/02 16:22
L5	1	3 and 4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/02 16:21
S1	35729	test$4 near5 (IC! or integrated adj circuit)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/02 16:18
S2	47	BOST and S1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:00
S3	5	(("3,733,587") or ("3,764,995")).PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/11/10 10:00
S4	9002	324/765,763,760,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:29

S5	35729	test$4 near5 (IC! or integrated adj circuit)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:30
S6	2798	S4 and S5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:30
S7	11	S6 and ancillary	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:31
S8	347	S6 and measur$4 and analyz$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:33
S9	1135	714/736,734.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:33
S10	487	S9 and S5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:33
S11	68	S10 and measur$4 and analyz$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:35
S12	200	702/118.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:34
S13	83	S12 and S5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:34
S14	18	S13 and measur$4 and analyz$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/10 10:34

S15	11941	324/755-765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/15 20:01
S16	5	"5931962"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/17 15:14
S17	5	(("3733587") or ("3764995")).PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/30 11:12
S18	9	("3733587").URPN.	USPAT	OR	ON	2005/03/30 14:14
S19	1	"3585599".PN.	USPAT; USOCR	OR	ON	2005/03/30 11:24
S20	2	"3518413".PN.	USPAT; USOCR	OR	ON	2005/03/30 11:24
S21	4055	control$4 adj card	USPAT	OR	ON	2005/03/30 14:15
S22	37240	test$4 near5 (IC! or integrated adj circuit)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/30 14:15
S23	73	S22 and S21	USPAT	OR	ON	2005/03/30 15:22
S24	4	S23 and 324/765,763,158.1.ccls.	USPAT	OR	ON	2005/03/30 15:41
S25	0	pluralilty near3 measur$4 adj unit	USPAT	OR	ON	2005/03/30 15:23
S26	1	pluralilty near3 measur$4	USPAT	OR	ON	2005/03/30 15:24
S27	123	plurality near3 measur$4 adj unit	USPAT	OR	ON	2005/03/30 15:24
S28	0	S27 and S24	USPAT	OR	ON	2005/03/30 15:24
S29	5	S27 and 324/765,763,158.1.ccls.	USPAT	OR	ON	2005/03/30 15:40
S30	11	measur$4 adj unit near5 socket	USPAT	OR	ON	2005/03/30 15:41
S31	2	S30 and 324/765,763,158.1.ccls.	USPAT	OR	ON	2005/03/30 15:42
S32	2189	324/765.ccls.	USPAT	OR	ON	2005/03/30 15:42
S33	448	S32 and socket	USPAT	OR	ON	2005/03/30 15:42
S34	35	S32 and socket with measur$4	USPAT	OR	ON	2005/03/30 15:43
S35	2	("5931962").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/30 19:23

S36	49	manufacturing adj2 (contact adj probe)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/30 19:24